## Application/Control No. O9/783,917 Applicant(s)/Patent Under Reexamination ALANARA, SEPPO Examiner Pablo N Tran Applicant(s)/Patent Under Reexamination ALANARA, SEPPO Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	к	US-			
	L	US-			
	М	US-			

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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.